

HIGH SPEED 2K X 16 DUAL-PORT SRAM

7133SA/LA 7143SA/LA

Features

High-speed access

- Commercial: 20/25/35/45/55/70/90ns (max.)
- Industrial: 25ns (max.)
- Military: 35/55/70/90ns (max.)
- Low-power operation
 - IDT7133/43SA
 Active: 1150mW (typ.)
 Standby: 5mW (typ.)
 - IDT7133/43LA
 Active: 1050mW (typ.)
 Standby: 1mW (typ.)
- Versatile control for write: separate write control for lower and upper byte of each port
- Functional Block Diagram

- MASTER IDT7133 easily expands data bus width to 32 bits or more using SLAVE IDT7143
- On-chip port arbitration logic (IDT7133 only)
- BUSY output flag on IDT7133; BUSY input on IDT7143
- Fully asynchronous operation from either port
- Battery backup operation-2V data retention
- TTL-compatible; single 5V (±10%) power supply
- Available in 68-pin ceramic PGA, Flatpack, PLCC and 100pin TQFP
- Military product compliant to MIL-PRF-38535 QML
- Industrial temperature range (-40°C to +85°C) is available for selected speeds
- Green parts available, see ordering information



NOTE:

 IDT7133 (MASTER): <u>BUSY</u> is open drain output and requires pull-up resistor. IDT7143 (SLAVE): <u>BUSY</u> is input.



Military, Industrial and Commercial Temperature Ranges

Description

The IDT7133/7143 are high-speed 2K x 16 Dual-Port Static RAMs. The IDT7133 is designed to be used as a stand-alone 16-bit Dual-Port RAM or as a "MASTER" Dual-Port RAM together with the IDT7143 "SLAVE" Dual-Port in 32-bit-or-more word width systems. Using the IDT MASTER/SLAVE Dual-Port RAM approach in 32-bit-or-wider memory system applications results in full-speed, error-free operation without the need for additional discrete logic.

Both devices provide two independent ports with separate control,



PinConfigurations^(1,2,3,4)

address, and I/O pins that permit independent, asynchronous access for reads or writes to any location in memory. An automatic power down feature, controlled by \overline{CE} , permits the on-chip circuitry of each port to enter a very low standby power mode.

Fabricated using CMOS high-performance technology. Low-power (LA) versions offer battery backup data retention capability, with each port typically consuming 200µW for a 2V battery.

The IDT7133/7143 devices have identical pinouts. Each is packed in a 68-pin ceramic PGA, 68-pin flatpack, 68-pin PLCC and 100-pin TQFP. Military grade product is manufactured in compliance with the latest revision of MIL-PRF-38535 QML, making it ideally suited to military temperature applications demanding the highest level of performance and reliability.

- 1. Both Vcc pins must be connected to the power supply to ensure reliable operation.
- 2. Both GND pins must be connected to the ground supply to ensure reliable operation.
- 3. PLG68 package body is approximately 0.95 in x 0.95 in x 0.17 in. FP68 package body is approximately 1.18 in x 1.18 in x 0.16 in.
- 4. This package code is used to reference the package diagram.





Pin Configurations^(1,2,3,4) (con't.)



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- 1. Both Vcc pins must be connected to the power supply to ensure reliable operation.
- 2. Both GND pins must be connected to the ground supply to ensure reliable operation.
- 3. GU68 package body is approximately 1.18 in x 1.18 in x 0.16 in.
- 4. This package code is used to reference the package diagram.
- 5. This text does not indicate orientation of the actual part-marking.

Pin Configurations^(1,2,3,4) (con't.)



NOTES:

- Both Vcc pins must be connected to the power supply to ensure reliable operation.
- 2. Both GND pins must be connected to the ground supply to ensure reliable operation.
- 3. PNG100 package body is approximately 14mm x 14mm x 1.4mm.
- 4. This package code is used to reference the package diagram.

Pin Names

Left Port	Right Port	Names		
<u>CE</u> L	Ē	Chip Enable		
R/Wlub	R/WRUB	Upper Byte Read/Write Enable		
R/WLLB	R/Wrlb	Lower Byte Read/Write Enable		
OEL	0E r	Output Enable		
Aol - A10l	Aor - A10r	Address		
I/O0L - I/O15L	I/O0r - I/O15r	Data Input/Output		
BUSYL	BUSYR	Busy Flag		
Vcc		Power		
G	ND	Ground		

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Military, Industrial and Commercial Temperature Ranges

Absolute Maximum Ratings⁽¹⁾

Symbol	Rating	Commercial & Industrial	Military	Unit
Vterm ⁽²⁾	Terminal Voltage with Respect to GND	-0.5 to +7.0	-0.5 to +7.0	V
Tbias	Temperature Under Bias	-55 to +125	-65 to +135	٥C
Tstg	Storage Temperature	-65 to +150	-65 to +150	٥C
Ρτ	Power Dissipation	2.0	2.0	W
Ιουτ	DC Output Current	50	50	mA

NOTES:

 Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

2. VTERM must not exceed Vcc + 10% for more than 25% of the cycle time or 10ns maximum, and is limited to \leq 20mA for the period of VTERM \geq Vcc + 10%.

Capacitance (TA = +25°C, f = 1.0mhz)

Symbol	Parameter ⁽¹⁾	Conditions ⁽²⁾	Мах.	Unit
Cin	Input Capacitance	Vin = 3dV	11	pF
Соит	Output Capacitance	Vout = 3dV	11	pF
				2746 tbl 03

NOTES:

1. This parameter is determined by device characterization but is not production tested.

 3dV references the interpolated capacitance when the input and output switch from 0V to 3V or from 3V to 0V.

Maximum Operating Temperature and Supply Voltage^(1,2)

Grade	Ambient Temperature	GND	Vcc
Military	-55°C to +125°C	0V	5.0V <u>+</u> 10%
Commercial	0°C to +70°C	0V	5.0V <u>+</u> 10%
Industrial	-40°C to +85°C	0V	5.0V <u>+</u> 10%

NOTES:

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1. This is the parameter TA. This is the "instant on" case temperature.

Recommended DC Operating Conditions

Symbol	Parameter	Min.	Тур.	Max.	Unit				
Vcc	Supply Voltage	4.5	5.0	5.5	V				
GND	Ground	0	0	0	V				
Vih	Input High Voltage	2.2		6.0 ⁽²⁾	V				
VIL	Input Low Voltage	-0.5 ⁽¹⁾		0.8	V				
	2746 tbl 05								

NOTES:

1. VIL (min.) = -1.5V for pulse width less than 10ns.

2. VTERM must not exceed Vcc + 10%.

DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range (Either port, Vcc = 5.0V ± 10%)

			7133SA 7143SA		7133LA 7143LA		
Symbol	Parameter	Test Conditions	Min.	Max.	Min.	Мах.	Unit
lu	Input Leakage Current ⁽¹⁾	Vcc = 5.5V, VIN = 0V to Vcc		10		5	μA
llo	Output Leakage Current	\overline{CE} = VIH, VOUT = 0V to VCC		10		5	μA
Vol	Output Low Voltage (I/Oo-I/O15)	Iol = 4mA		0.4		0.4	V
Vol	<u>Open D</u> rain Output Low Voltage (BUSY)	Iol = 16mA		0.5		0.5	V
Vон	Output High Voltage	Ioh = -4mA	2.4	-	2.4	_	V

NOTE:

1. At Vcc \leq 2.0V, input leakages are undefined.

2746 tbl 06

2746 tbl 04



DC Electrical Characteristics Operating Temperature and Supply Voltage Range⁽²⁾ ($Vcc = 5.0V \pm 10\%$)

							7133 7143 Com'l	X20	7133 7143 Com'l	X25	7133 7143 Cor & Mill	X35 n'l	
Symbol	Parameter	Test Condition	Versi	on	Typ. ⁽¹⁾	Max.	Typ. ⁽¹⁾	Max.	Typ. ⁽¹⁾	Мах.	Unit		
ICC	Dynamic Operating Current (Both Ports Active)	$\overline{CE} = VIL$, Outputs Disabled f = fMAX ⁽³⁾	COM'L	S L	250 230	310 280	250 230	300 270	240 210	295 250	mA		
	(DUIT POILS ACTIVE)	I = IMAX**	MIL & IND	S L			250 230	330 300	240 220	325 295			
ISB1	Standby Current (Both Ports - TTL	\overline{CEL} and $\overline{CER} = VIH$	COM'L	S L	25 25	80 70	25 25	80 70	25 25	70 60	mA		
	Level Inputs)	$f = fMAX^{(3)}$	MIL & IND	S L			25 25	90 80	25 25	75 65			
ISB2	Standby Current (One Port - TTL	$\overline{CE}^*A^* = VIL \text{ and } \overline{CE}^*B^* = VIH^{(4)}$ f=fMAX ⁽³⁾	COM'L	S L	140 120	200 180	140 100	200 170	120 100	180 160	mA		
	Level Inputs)	Active Port Outputs Disabled	MIL & IND	S L			140 100	230 190	120 100	200 180			
ISB3	Full Standby Current (Both Ports - CMOS Level Inputs)	Both Ports CEL and CER > Vcc - 0.2V VIN > Vcc - 0.2V or	COM'L	S L	1.0 0.2	15 5	1.0 0.2	15 4	1.0 0.2	15 4	mA		
	CIVIOS Level Inpuis)	VIN > VCC - 0.2V OI $VIN < 0.2V, f = 0^{(4)}$	MIL & IND	S L			1.0 0.2	30 10	1.0 0.2	30 10			
ISB4	Full Standby Current (One Port -	$\overline{CE}^*A^* < 0.2V$ and $\overline{CE}^*B^* > VCC - 0.2V^{(5)}$	COM'L	S L	140 120	190 170	140 120	190 170	120 100	170 150	mA		
	ĊMOS Level Inputs)	$ \begin{array}{l} \text{VIN} > \text{VCC} - 0.2 \text{V } \text{or } \text{VIN} < 0.2 \text{V} \\ \text{Active Port Outputs Disabled} \\ f = \text{fMAX}^{(3)} \end{array} $	MIL & IND	S L			140 120	220 200	120 100	190 170			

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					7133X45 7143X45 Com'l Only		7133X55 7143X55 Com'l, Ind & Military		7133X70/90 7143X70/90 Com'l & Military		
Symbol	Parameter	Test Condition	Versi	on	Тур. ⁽¹⁾	Мах.	Typ. ⁽¹⁾	Мах.	Typ. ⁽¹⁾	Max.	Unit
ICC	Dynamic Operating Current	$\overline{CE} = VIL$, Outputs Disabled	COM'L	S L	230 210	290 250	230 210	285 250	230 210	280 250	mA
(Both Ports Active)		MIL & IND	S L			230 210	315 285	230 210	310 280		
ISB1 Standby Current (Both Ports - TTL Level Inputs)	Both Ports - TTL	COM'L	S L	25 25	75 65	25 25	70 60	25 25	70 60	mA	
		MIL & IND	S L			25 25	80 70	25 25	75 65		
ISB2	(One Port - TTL f=fMAX ⁽³⁾	f=fMAX ⁽³⁾	COM'L	S L	120 100	190 170	120 100	180 160	120 100	180 160	mA
	Level Inputs)	Active Port Outputs Disabled	MIL & IND	S L			120 100	210 190	120 100	200 180	
ISB3	Full Standby Current (Both Ports -	Both Ports \overline{CEL} and $\overline{CER} > Vcc - 0.2V$	COM'L	S L	1.0 0.2	15 4	1.0 0.2	15 4	1.0 0.2	15 4	mA
ČMOS Level Inputs)	Level Inputs) $ \begin{array}{l} \text{VIN} > \text{Vcc} - 0.2 \text{V or} \\ \text{VIN} < 0.2 \text{V}, \ \text{f} = 0^{(4)} \end{array} $	MIL & IND	S L			1.0 0.2	30 10	1.0 0.2	30 10		
ISB4	(One Port - CE"B" >	$\overline{CE}^*A^* < 0.2V$ and $\overline{CE}^*B^* > VCC - 0.2V^{(5)}$	COM'L	S L	120 100	180 160	120 100	170 150	120 100	170 150	mA
ĊMOS Level Inputs)	Active Port Outputs Disabled	MIL & IND	S L			120 100	200 180	120 100	190 170		

NOTES:

1. Vcc = 5V, TA = +25°C for Typ., and are not production tested. Icccc = 180mA (typ.)

2. 'X' in part number indicates power rating (SA or LA)

3. At f = fMAX, address and control lines (except Output Enable) are cycling at the maximum frequency read cycle of 1/ trc, and using "AC Test Conditions" of input levels of GND to 3V.

4. f = 0 means no address or control lines change. Applies only to inputs at CMOS level standby.

5. Port "A" may be either left or right port. Port "B" is the opposite from port "A".



Data Retention Characteristics (LA Version Only) VLC = 0.2V, VHC = VCC - 0.2V

			7133LA/7143LA				
Symbol	Parameter	Test Co	Test Condition Min. Typ. ⁽¹⁾ Max.				Unit
Vdr	Vcc for Data Retention	Vcc = 2V		2.0	_		V
ICCDR	Data Retention Current	CE ≥ VHC	MIL. & IND.	_	100	4000	μA
		$V_{IN} \ge V_{HC} \text{ or } \le V_{LC}$	COM'L.	_	100	1500]
tcdr ⁽³⁾	Chip Deselect to Data Retention Time			0	_	_	V
tR ⁽³⁾	Operation Recovery Time			trc ⁽²⁾	_	-	V
						2	746 tbl 0

NOTES:

1. Vcc = 2V, TA = $+25^{\circ}$ C, and are not production tested.

2. trc = Read Cycle Time

3. This parameter is guaranteed by device characterization but is not production tested.

Data Retention Waveform



AC Test Conditions

Input Pulse Levels	GND to 3.0V
Input Rise/Fall Times	5ns Max.
Input Timing Reference Levels	1.5V
Output Reference Levels	1.5V
Output Load	Figures 1, 2 and 3

2746 tbl 09



Figure 1. AC Output Test Load



Jun.16.21



AC Electrical Characteristics Over the Operating Temperature and Supply Voltage⁽³⁾

			7133X20 7143X20 Com'l Only		7133X25 7143X25 Com'l & Ind		7133X35 7143X35 Com'l & Military	
Symbol	Parameter	Min.	Мах.	Min.	Мах.	Min.	Max.	Unit
READ CYCLE								
trc	Read Cycle Time	20		25		35		ns
taa	Address Access Time	_	20	_	25		35	ns
tace	Chip Enable Access Time	_	20		25	_	35	ns
taoe	Output Enable Access Time		12		15		20	ns
toн	Output Hold from Address Change	0		0	_	0	_	ns
tLZ	Output Low-Z Time ^(1,2)	0		0	_	0		ns
tHZ	Output High-Z Time ^(1,2)		12		15		20	ns
tpu	Chip Enable to Power Up Time ⁽²⁾	0		0		0		ns
tpd	Chip Disable to Power Down Time ⁽²⁾		20	_	50		50	ns

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2746 tbl 10b

		7133X45 7143X45 Com'l Only		7133X55 7143X55 Com'l, Ind & Military		7133X70/90 7143X70/90 Com'l & Military		
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Max.	Unit
READ CYCLE								
tRC	Read Cycle Time	45		55		70/90		ns
taa	Address Access Time		45		55		70/90	ns
tace	Chip Enable Access Time		45		55		70/90	ns
taoe	Output Enable Access Time		25		30		40/40	ns
tон	Output Hold from Address Change	0		0		0/0		ns
tLZ	Output Low-Z Time ^(1,2)	0		5		5/5		ns
tнz	Output High-Z Time ^(1,2)		20		20		25/25	ns
tpu	Chip Enable to Power Up Time ⁽²⁾	0		0		0/0		ns
tpd	Chip Disable to Power Down Time ⁽²⁾		50		50		50/50	ns

NOTES:

1. Transition is measured 0mV from Low or High-impedance voltage with load (Figure 2).

2. This parameter is guaranteed by device characterization, but is not production tested.

3. 'X' in part number indicates power rating (SA or LA).



TIMING WAVEFORM OF READ CYCLE NO. 1, EITHER SIDE⁽⁵⁾



TIMING WAVEFORM OF READ CYCLE NO. 2, EITHER SIDE⁽⁵⁾



NOTES:

1. Timing depends on which signal is asserted last, \overline{OE} or \overline{CE} . 2. Timing depends on which signal is de-asserted first, \overline{OE} or \overline{CE} .

- 3. tbdd delay is required only in a case where the opposite port is completing a write operation to the same address location. For simultaneous read operations, BUSY has no relationship to valid output data.
- 4. Start of valid data depends on which timing becomes effective last, tAOE, tACE, tAA, or tBDD.

5. $R/\overline{W} = V_{H}$, and the address is valid prior to or coincidental with \overline{CE} transition LOW.



AC Electrical Characteristics Over the Operating Temperature and Supply Voltage⁽⁵⁾

		7133X20 7143X20 Com'l Only		7133X25 7143X25 Com'l & Ind		7133X35 7143X35 Com'l & Military		
Symbol	Parameter	Min.	Мах.	Min.	Мах.	Min.	Max.	Unit
WRITE CYCLI	- -	-						
twc	Write Cycle Time ⁽³⁾	20	_	25		35	_	ns
tew	Chip Enable to End-of-Write	15	_	20		25	_	ns
taw	Address Valid to End-of-Write	15	_	20	—	25	_	ns
tas	Address Set-up Time	0		0		0	_	ns
twp	Write Pulse Width	15	_	20		25	_	ns
twr	Write Recovery Time	0	_	0	—	0	_	ns
tow	Data Valid to End-of-Write	15	_	15	_	20	_	ns
tHZ	Output High-Z Time ^(1,2)	—	12		15		20	ns
tDH	Data Hold Time ⁽⁴⁾	0		0		0	_	ns
twz	Write Enable to Output in High-Z ^(1,2)	_	12		15		20	ns
tow	Output Active from End-of-Write ^(1,2,4)	0		0		0	_	ns

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			7133X45 7143X45 Com'l Only		7133X55 7143X55 Com'l, Ind & Military		7133X70/90 7143X70/90 Com'l & Military	
Symbol	Parameter	Min.	Max.	Min.	Мах.	Min.	Мах.	Unit
WRITE CYCL	E							
twc	Write Cycle Time ⁽³⁾	45		55		70/90	_	ns
tew	Chip Enable to End-of-Write	30		40		50/50	_	ns
taw	Address Valid to End-of-Write	30	_	40		50/50		ns
tas	Address Set-up Time	0		0		0/0	-	ns
twp	Write Pulse Width	30	_	40		50/50		ns
twr	Write Recovery Time	0		0	-	0/0		ns
tow	Data Valid to End-of-Write	20	_	25		30/30	_	ns
tHZ	Output High-Z Time ^(1,2)		20		20		25/25	ns
tdн	Data Hold Time ⁽⁴⁾	5	_	5		5/5	_	ns
twz	Write Enable to Output in High-Z ^(1,2)		20	_	20	_	25/25	ns
tow	Output Active from End-of-Write ^(1,2,4)	5		5		5/5	_	ns
								2746 tbl 11b

NOTES:

1. Transition is measured 0mV from Low or High-impedance voltage from the Output Test Load (Figure 2).

2. This parameter is guaranteed by device characterization but not production tested.

3. For MASTER/SLAVE combination, twc = tBAA + twR + twP, since R/\overline{W} = VIL must occur after tBAA.

4. The specification for tDH must be met by the device supplying write data to the RAM under all operation conditions. Although tDH and tow values will vary over voltage and temperature, the actual tDH will always be smaller than the actual tow.

5. 'X' in part number indicates power rating (SA or LA).





AC Electrical Characteristics Over the Operating Temperature and Supply Voltage⁽⁶⁾

		714	7133X20 7143X20 Com'l Only		7133X25 7143X25 Com'l & Ind		7133X35 7143X35 Com'l & Military	
Symbol	Parameter	Min.	Max.	Min.	Мах.	Min.	Max.	Unit
	G (For MASTER 71V33)							
t BAA	BUSY Access Time from Address		20		20		30	ns
tbda	BUSY Disable Time from Address		20	_	20		30	ns
t BAC	BUSY Access Time from Chip Enable	_	20	_	20	_	25	ns
tBDC	BUSY Disable Time from Chip Enable		17		20	_	25	ns
twdd	Write Pulse to Data Delay ⁽¹⁾		40		50	_	60	ns
todd	Write Data Valid to Read Data Delay ⁽¹⁾		30		35		45	ns
tbdd	BUSY Disable to Valid Data ⁽²⁾		25	-	30	-	35	ns
taps	Arbitration Priority Set-up Time ⁽³⁾	5	_	5	_	5		ns
twн	Write Hold After BUSY ⁽⁵⁾	20		20	_	25		ns
BUSY INPU	f TIMING (For SLAVE 71V43)							
twв	BUSY Input to Write ⁽⁴⁾	0	_	0		0		ns
twн	Write Hold After BUSY ⁽⁵⁾	20	_	20	-	25		ns
twdd	Write Pulse to Data Delay ⁽¹⁾		40		50		60	ns
todd	Write Data Valid to Read Data Delay ⁽¹⁾		30		35		45	ns

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		714	7143X45 7' Com'l Only Co		7133X55 7143X55 Com'l, Ind & Military		7133X70/90 7143X70/90 Com'l & Military	
Symbol	Parameter	Min.	Мах.	Min.	Max.	Min.	Мах.	Unit
BUSY TIMI	NG (For MASTER 71V33)							
t BAA	BUSY Access Time from Address		40		40		45/45	ns
tbda	BUSY Disable Time from Address	—	40	_	40		45/45	ns
t BAC	BUSY Access Time from Chip Enable	—	30	_	35		35/35	ns
tBDC	BUSY Disable Time from Chip Enable	—	25	_	30	—	30/30	ns
twdd	Write Pulse to Data Delay ⁽¹⁾		80	_	80		90/90	ns
todd	Write Data Valid to Read Data Delay ⁽¹⁾		55	_	55		70/70	ns
tBDD	BUSY Disable to Valid Data ⁽²⁾	—	40	_	40		40/40	ns
taps	Arbitration Priority Set-up Time ⁽³⁾	5	_	5		5/5		ns
twн	Write Hold After BUSY ⁽⁵⁾	30	_	30		30/30		ns
BUSY INPL	JT TIMING (For SLAVE 71V43)	-						
twв	BUSY Input to Write ⁽⁴⁾	0	_	0		0/0		ns
twн	Write Hold After BUSY ⁽⁵⁾	30	_	30		30/30		ns
twdd	Write Pulse to Data Delay ⁽¹⁾	—	80	_	80		90/90	ns
todd	Write Data Valid to Read Data Delay ⁽¹⁾	_	55		55		70/70	ns

NOTES:

Port-to-port delay through RAM cells from writing port to reading port, refer to "Timing Waveform of Write with Port-to-Port Read and Busy". 1.

tBDD is calculated parameter and is greater of 0, twod - twp (actual) or tbbd - tbw (actual). 2.

3. To ensure that the earlier of the two ports wins.

To ensure that the write cycle is inhibited on port "B" during contention on port "A". To ensure that the write cycle is completed on port "B" after contention on port "A". 'X' in part number indicates power rating (SA or LA). 4.

5. 6.



Timing Waveform of Write Cycle No. 1 (R/W Controlled Timing)^(1,5,8)



Write Cycle No. 2 (CE Controlled Timing)^(1,5)



- 1. R/\overline{W} or \overline{CE} must be HIGH during all address transitions.
- 2. A write occurs during the overlap (tew or twp) of a $\overline{CE} = V_{IL}$ and a $R/\overline{W} = V_{IL}$. 3. twr is measured from the earlier of \overline{CE} or R/\overline{W} going HIGH to the end of the write cycle.
- 4. During this period, the I/O pins are in the output state, and input signals must not be applied.
- 5. If the CE LOW transition occurs simultaneously with or after the RW LOW transition, the outputs remain in the High-impedance state.
- 6. Timing depends on which enable signal (\overline{CE} or $\overline{R/W}$) is asserted last.
- Timing depends on which enable signal is de-asserted first, \overline{CE} or \overline{OE} . 7
- If \overline{OE} is LOW during a RW controlled write cycle, the write pulse width must be the larger of twp or (twz + tow) to allow the I/O drivers to turn off and data to be placed 8. on the bus for the required tow. If OE is HIGH during an RIW controlled write cycle, this requirement does not apply and the write pulse can be as short as the specified twp.
- 9. $\dot{R/W}$ for either upper or lower byte.



Timing Waveform of Write with Port-to-Port Read and **BUSY**^(1,2,3)



1. To ensure that the earlier of the two ports wins, taps is ignored for Slave (IDT7143).

- 2. $\overline{CE}L = \overline{CE}R = VIL$
- 3. $\overline{OE} = V_{IL}$ for the reading port.

4. All timing is the same for left and right ports. Port "A" may be either the left or right port. Port "B" is the port opposite from port "A".

Timing Waveform of Write with **BUSY**⁽³⁾



NOTES:

1. twn must be met for both BUSY input (IDT7143, slave) and output (IDT7133, master).

2. BUSY is asserted on port "B" blocking R/W"B", until BUSY"B" goes HIGH.

3. All timing is the same for left and right ports. Port "A" may be either left or right port. Port "B" is the opposite from port "A".



Timing Waveform of **BUSY** Arbitration Controlled by **CE** Timing⁽¹⁾



Timing Waveform of **BUSY** Arbitration Controlled by Addresses⁽¹⁾



- 1. All timing is the same for left and right ports. Port "A" may be either the left or right port. Port "B" is the port opposite from port "A".
- 2. If taps is not satisfied, the BUSY will be asserted on one side or the other, but there is no guarantee on which side BUSY will be asserted (IDT7133 only).



Functional Description

The IDT7133/43 provides two ports with separate control, address and I/O pins that permit independent access for reads or writes to any location in memory. The IDT7133/43 has an automatic power down feature controlled by CE. The CE controls on-chip power down circuitry that permits the respective port to go into a standby mode when not selected (CE HIGH). When a port is enabled, access to the entire memory array is permitted. Non-contention READ/WRITE conditions are illustrated in Truth Table 1.

Busy Logic

Busy Logic provides a hardware indication that both ports of the RAM have accessed the same location at the same time. It also allows one of the two accesses to proceed and signals the other side that the RAM is "busy". The BUSY pin can then be used to stall the access until the operation on the other side is completed. If a write operation has been attempted from the side that receives a BUSY indication, the write signal is gated internally to prevent the write from proceeding.

The use of BUSY logic is not required or desirable for all applications. In some cases it may be useful to logically OR the BUSY outputs together and use any BUSY indication as an interrupt source to flag the event of an illegal or illogical operation. If the write inhibit function of BUSY logic is not desirable, the BUSY logic can be disabled by using the IDT7143 (SLAVE). In the IDT7143, the BUSY pin operates solely as a write inhibit input pin. Normal operation can be programmed by tying the BUSY pins HIGH. If desired, unintended write operations can be prevented to a port by tying the BUSY pin for that port LOW. The BUSY outputs on the IDT 7133 RAM are open drain and require pullup resistors.

Width Expansion with Busy Logic Master/Slave Arrays

When expanding an IDT7133/43 RAM array in width while using BUSY logic, one master part is used to decide which side of the RAM array will receive a BUSY indication, and to output that indication. Any number of slaves to be addressed in the same address range as the master, use the BUSY signal as a write inhibit signal. Thus on the IDT7133 RAM the BUSY pin is an output and on the IDT7143 RAM, the BUSY pin is an input (see Figure 3).



Figure 4. Busy and chip enable routing for both width and depth expansion with the IDT7133 (MASTER) and the IDT7143 (SLAVE).

Expanding the data bus width to 32 bits or more in a Dual-Port RAM system implies that several chips will be active at the same time. If each chip includes a hardware arbitrator, and the addresses for each chip arrive at the same time, it is possible that one will activate its BUSYL while another activates its BUSYR signal. Both sides are now BUSY and the CPUs will await indefinitely for their port to become free.

To avoid the "Busy Lock-Out" problem, IDT has developed a MASTER/SLAVE approach where only one hardware arbitrator, in the MASTER, is used. The SLAVE has **BUSY** inputs which allow an interface to the MASTER with no external components and with a speed advantage over other systems.

When expanding Dual-Port RAMs in width, the writing of the SLAVE RAMs must be delayed until after the BUSY input has settled. Otherwise, the SLAVE chip may begin a write cycle during a contention situation. Conversely, the write pulse must extend a hold time past BUSY to ensure that a write cycle takes place after the contention is resolved. This timing is inherent in all Dual-Port memory systems where more than one chip is active at the same time.

The write pulse to the SLAVE should be delayed by the maximum arbitration time of the MASTER. If, then, a contention occurs, the write to the SLAVE will be inhibited due to **BUSY** from the MASTER.

Truth Table I – Non-Contention Read/Write Control⁽⁴⁾

LEFT OR RIGHT PORT ⁽¹⁾						
R/WLB	R/WUB	ĒĒ	ŌĒ	I/O0-7	I/O8-15	Function
Х	Х	Н	Х	Z	Z	Port Disabled and in Power Down Mode, ISB2, ISB4
Х	Х	Н	Х	Z	Z	CER = CEL = VIH, Power Down Mode, ISB1 or ISB3
L	L	L	Х	DATAIN	DATAIN	Data on Lower Byte and Upper Byte Written into $Memory^{(\!2\!)}$
L	Н	L	L	DATAIN	DATAout	Data on Lower Byte Written into $\text{Memory}^{(2)},$ Data in Memory Output on Upper $\text{Byte}^{(3)}$
Н	L	L	L	DATAOUT	DATAIN	Data in Memory Output on Lower Byte $^{(3)},$ Data on Upper Byte Written into ${\rm Memory}^{(\!\!\!\!2)}$
L	Н	L	Н	DATAIN	Z	Data on Lower Byte Written into Memory ⁽²⁾
Н	L	L	Н	Z	DATAIN	Data on Upper Byte Written into Memory ⁽²⁾
Н	Н	L	L	DATAOUT	DATAOUT	Data in Memory Output on Lower Byte and Upper Byte
Н	Н	L	Н	Z	Z	High Impedance Outputs

NOTES:

1. Aol - A10L≠Aor - A10r

2. If $\overline{\text{BUSY}}$ = LOW, data is not written.

3. If **BUSY** = LOW, data may not be valid, see twod and todd timing.

4. "H" = HIGH, "L" = LOW, "X" = Don't Care, "Z" = High-Impedance, "LB" = Lower Byte, "UB" = Upper Byte

Truth Table II — Address **BUSY** Arbitration

	In	puts	Out	puts	
ĒĒ∟	Č ER	Aol-A1ol Aor-A1or	BUS YL ⁽¹⁾	BUSY _R ⁽¹⁾	Function
Х	Х	NO MATCH	Н	Н	Normal
Н	Х	MATCH	Н	Н	Normal
Х	Н	MATCH	Н	Н	Normal
L	L	MATCH	(2)	(2)	Write Inhibit ⁽³⁾
					2746 tbl 14

NOTES:

- Pins BUSYL and BUSYR are both outputs on the IDT7133 (MASTER). Both are inputs on the IDT7143 (SLAVE). On Slaves the BUSY input internally inhibits writes.
- "L" if the inputs to the opposite port were stable prior to the address and enable inputs of this port. "H" if the inputs to the opposite port became stable after the address and enable inputs of this port. If tAPS is not met, either BUSYL or BUSYR = ViL will result BUSYL and BUSYR outputs can not be LOW simultaneously.
- Writes to the left port are internally ignored when BUSYL outputs are driving LOW regardless of actual logic level on the pin. Writes to the right port are internally ignored when BUSYR outputs are driving LOW regardless of actual logic level on the pin.

Military, Industrial and Commercial Temperature Ranges

2746 tbl 13

7133SA/LA, 7143SA/LA High-Speed 2K x 16 Dual-Port RAM Military, Industrial and Commercial Temperature Ranges Ordering Information 999 XXXXX ____A А А A А Device Power Package Process/ Speed Temperature Range Туре Blank Tube or Tray 8 Tape and Reel Commercial (0°C to +70°C) Industrial (-40°C to +85°C) Military (-55°C to +125°C) Compliant to MIL-PRF-38535 QML Blank [⁽¹⁾ В G⁽²⁾ Green 68-pin PLCC (PLG68) 68-pin PGA (GU68) 68-pin Flatpack (FP68) 100-pin TQFP (PNG100) J G F PF Commercial Only Commercial & Industrial Commercial & Military Commercial & Military Commercial & Military Commercial & Military 20 25 35 45 55 70 90 Speed in nanoseconds

NOTES:

1. Contact your local sales office for industrial temp. range for other speeds, packages and powers.

 Green parts available. For specific speeds, packages and powers contact your local sales office. LEAD FINISH (SnPb) parts are Obsolete excluding PGA and Flatpack. Product Discontinuation Notice - PDN# SP-17-02 Note that information regarding recently obsoleted parts are included in this datasheet for customer convenience.

Orderable Part Information

Speed (ns)	Orderable Part ID	Pkg. Code	Pkg. Type	Temp. Grade
20	7133LA20G	GU68	PGA	С
	7133LA20JG	PLG68	PLCC	С
	7133LA20JG8	PLG68	PLCC	С
	7133LA20PFG	PNG100	TQFP	С
	7133LA20PFG8	PNG100	TQFP	С
25	7133LA25G	GU68	PGA	С
	7133LA25JGI	PLG68	PLCC	I
	7133LA25JGI8	PLG68	PLCC	I
	7133LA25PFGI	PNG100	TQFP	I
	7133LA25PFGI8	PNG100	TQFP	I
35	7133LA35FB	FP68	FPACK	М
	7133LA35G	GU68	PGA	С
	7133LA35GB	GU68	PGA	М
45	7133LA45G	GU68	PGA	С
55	7133LA55FB	FP68	FPACK	М
	7133LA55G	GU68	PGA	С
	7133LA55GB	GU68	PGA	М
70	7133LA70G	GU68	PGA	С
	7133LA70GB	GU68	PGA	М
90	7133LA90G	GU68	PGA	С
	7133LA90GB	GU68	PGA	М

Speed (ns)	Orderable Part ID	Pkg. Code	Pkg. Type	Temp. Grade
20	7133SA20G	GU68	PGA	С
25	7133SA25G	GU68	PGA	С
35	7133SA35FB	FP68	FPACK	М
	7133SA35G	GU68	PGA	С
	7133SA35GB	GU68	PGA	М
	7133SA35PFG	PNG100	TQFP	С
	7133SA35PFG8	PNG100	TQFP	С
45	7133SA45G	GU68	PGA	С
55	7133SA55FB	FP68	FPACK	М
	7133SA55G	GU68	PGA	С
	7133SA55GB	GU68	PGA	М
70	7133SA70G	GU68	PGA	С
	7133SA70GB	GU68	PGA	М
90	7133SA90G	GU68	PGA	С
	7133SA90GB	GU68	PGA	М

32K (2K x 16-Bit) MASTER Dual-Port RAM 32K (2K x 16-Bit) SLAVE Dual-Port RAM

2746 drw 16

Low Power Standard Power

LA SA

7133 7143



Military, Industrial and Commercial Temperature Ranges

Speed (ns)	Orderable Part ID	Pkg. Code	Pkg. Type	Temp. Grade
20	7143LA20G	GU68	PGA	С
	7143LA20JG	PLG68	PLCC	С
	7143LA20JG8	PLG68	PLCC	С
25	7143LA25G	GU68	PGA	С
35	7143LA35FB	FP68	FPACK	М
	7143LA35G	GU68	PGA	С
	7143LA35GB	GU68	PGA	М
55	7143LA55G	GU68	PGA	С
	7143LA55GB	GU68	PGA	М
70	7143LA70GB	GU68	PGA	М
90	7143LA90GB	GU68	PGA	М

Speed (ns)	Orderable Part ID	Pkg. Code	Pkg. Type	Temp. Grade
20	7143SA20G	GU68	PGA	С
25	7143SA25G	GU68	PGA	С
35	7143SA35FB	FP68	FPACK	М
	7143SA35G	GU68	PGA	С
	7143SA35GB	GU68	PGA	М
55	7143SA55G	GU68	PGA	С
	7143SA55GB	GU68	PGA	М
70	7143SA70GB	GU68	PGA	М
90	7143SA90GB	GU68	PGA	М

Orderable Part Information (con't)

Datasheet Document History

12/18/98:		Initiated datasheet document history
		Converted to new format
		Cosmetic and typographical corrections
		Added additional notes to pin configurations
	Page 2	Corrected PN100 pinout
02/17/99:		Corrected PF ordering code
030/9/99:		Cosmetic and typographical corrections
06/09/99:		Changed drawing format
10/01/99:		Added Industrial Temperature Ranges and removed corresponding notes
11/10/99:		Replaced IDT logo
04/01/00:		Changed ±500mV to 0mV in notes
	Page 2	Fixed overbar in pinout
06/26/00:	Page 4	Increased storage temperature parameters
		Clarified TA parameter
	Page 5	DC Electrical parameters-changed wording from "open" to "disabled"
01/31/06:	Page 1	Added green availability to features
	Page 16	Added green indicator for ordering information
10/21/08:	Page 16	Removed "IDT" from orderable part number
01/16/13:	Page 1, 5, 7, 9 &10	Removed Military 25ns & 45ns & Industrial 35ns speed grades from Features and from the headers of the
		MIL & IND of the DC Chars and AC Chars tables to indicate this change
	Page 5	Removed the Typ & Max values for the MIL & IND temp range from the 7133x45 and 7143x45 speed grade
		offering from the DC Chars tables to indicate this change, see table 07b
	Page 4	Removed annotation for footnote 3 in the Absolute Maximum Ratings table
	Page 8 & 9	Typo/correction
	Page 16	Added T& R indicator to and removed Military 25ns & 45ns & Industrial 35ns speed
		grades from the ordering information
		Product Discontinuation Notice - PDN# SP-17-02
		Last time buy expires June 15, 2018
08/13/19:		Page 1 & 16 Deleted obsolete Industrial speed 55ns
		Page 2 Rotated PLG68 PLCC and PNG100 TQFP pin configurations to accurately
		reflect pin 1 orientation
		Page 16 Added Orderable Part Information
06/16/21:		Pages 1-19 Rebranded as Renesas datasheet
		Page 2 Rotated FP68 Flatpack pin configuration to accurately reflect pin 1 orientation



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